


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527911	<b>Applicant(s)/Patent Under Reexamination</b>  KNEE ET AL.
	<b>Examiner</b>  EUENG-NAN YE H	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(382/172) text search - see search outputs	2008/02/06	ey
(382/173,164,171) text search - see search outputs	2008/03/14	ey
EAST text search - see search outputs	2008/02/06	ey
PALM inventor search - see search outputs	2008/02/28	ey
PTO PLUS search - see search outputs	2008/02/06	ey
IEEE search - see search outputs	2008/03/17	ey

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